

Appli	catio	n/Con	trol	No.

Applicant(s)/Patent under Reexamination

DAVIS, PHILIP Art Unit

Examiner
Anthony Fick

10/644,575

1753

SEARCHED				
Class	Subclass	Date	Examiner	
136	205	12/15/2006	ADF	
136	200-242	12/15/2006	ADF	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH) .
	DATE	EXMR
See EAST search history	12/15/2006	ADF
Inventor search	12/15/2006	ADF
Consulted with Jeffrey Barton and Nam Nguyen	12/18/2006	ADF
Google scholar search for inventor and keywords	12/15/2006	ADF